

CSD13381F4 12V N 沟道 FemtoFET™ MOSFET

1 特性

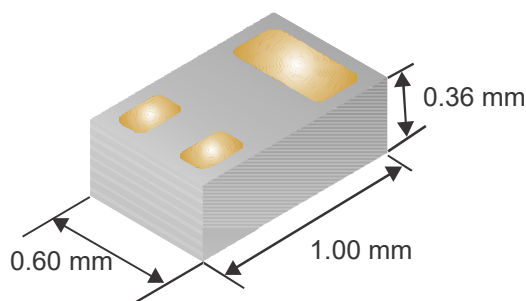
- 低导通电阻
- 低 Q_g 和 Q_{gd}
- 低阈值电压
- 超小封装尺寸 (0402 外壳尺寸)
 - 1.0mm × 0.6mm
- 超薄型封装
 - 最大高度: 0.36mm
- 集成型 ESD 保护二极管
 - 额定值 > 4kV HBM
 - 额定值 > 2kV CDM
- 无铅且无卤素
- 符合 RoHS

2 应用

- 针对负载开关应用进行了优化
- 针对通用开关应用进行了优化
- 单节电池应用
- 手持式和移动类应用

3 说明

此 140mΩ、12V N 沟道 FemtoFET™ MOSFET 技术经过设计和优化, 能够尽可能减小许多手持式和移动应用中的空间占用。这项技术能够在替代标准小信号 MOSFET 的同时将封装尺寸减小至少 60%。



典型器件尺寸

产品概要

$T_A = 25^\circ\text{C}$		典型值	单位
V_{DS}	漏源电压	12	V
Q_g	栅极电荷总量 (4.5V)	1060	pC
Q_{gd}	栅极电荷 (栅漏极)	140	pC
$R_{DS(on)}$	漏源导通电阻	$V_{GS} = 1.8\text{V}$	310 mΩ
		$V_{GS} = 2.5\text{V}$	170 mΩ
		$V_{GS} = 4.5\text{V}$	140 mΩ
$V_{GS(th)}$	阈值电压	0.85	V

订购信息

器件 ⁽¹⁾	数量	包装介质	封装	配送
CSD13381F4	3000	7 英寸卷带	Femto (0402) 1.0mm × 0.6mm 无引线 SMD	卷带包装
CSD13381F4T	250			

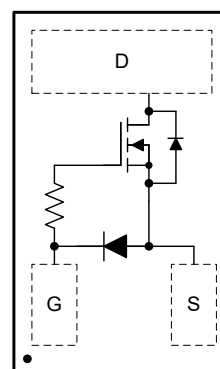
(1) 如需了解所有可用封装, 请参阅数据表末尾的可订购产品附录。

绝对最大额定值

$T_A = 25^\circ\text{C}$ 时测得, 除非另外注明		值	单位
V_{DS}	漏源电压	12	V
V_{GS}	栅源电压	8	V
I_D	持续漏极电流, $T_A = 25^\circ\text{C}$ 时测得 ⁽¹⁾	2.1	A
I_{DM}	脉冲漏极电流, $T_A = 25^\circ\text{C}$ ⁽²⁾	7	A
I_G	持续栅极钳位电流	35	mA
	脉冲栅极钳位电流 ⁽²⁾	350	
P_D	功率耗散 ⁽¹⁾	500	mW
ESD 等级	人体放电模型 (HBM)	4	kV
	充电器件模型 (CDM)	2	kV
T_J 、 T_{stg}	运行结温和贮存温度范围	-55 至 150	°C
E_{AS}	雪崩能量, 单脉冲 $I_D = 7.4\text{A}$, $L = 0.1\text{mH}$, $R_G = 25\Omega$	2.7	mJ

(1) 典型 $R_{\theta JA} = 90^\circ\text{C/W}$ (在 0.06 英寸 (1.52mm) 厚的 FR4 PCB 上安装 1 平方英寸 (6.45cm²)、2oz、0.071mm 厚的铜焊盘时)。

(2) 脉冲持续时间 $\leq 300 \mu\text{s}$, 占空比 $\leq 2\%$



顶视图



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4 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision E (October 2021) to Revision F (January 2022) Page

- 将特性中的最大高度从“0.35mm”更改为“0.36mm” **1**
- 将典型器件尺寸中的封装高度从“0.35mm”更改为“0.36mm” **1**
- Changed package height from "0.35 mm" to "0.36 mm" in *Mechanical Dimensions* **8**

Changes from Revision D (May 2015) to Revision E (October 2021) Page

- Added footnote with link to support document..... **9**

Changes from Revision C (September 2014) to Revision D (May 2015) Page

- Corrected typo for I_{GSS} Test Condition **3**

5 Specifications

5.1 Electrical Characteristics

(T_A = 25°C unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
STATIC CHARACTERISTICS							
BV _{DSS}	Drain-to-Source Voltage	V _{GS} = 0 V, I _{DS} = 250 μ A	12			V	
I _{DSS}	Drain-to-Source Leakage Current	V _{GS} = 0 V, V _{DS} = 9.6 V	100			nA	
I _{GSS}	Gate-to-Source Leakage Current	V _{DS} = 0 V, V _{GS} = 8 V	50			nA	
V _{GS(th)}	Gate-to-Source Threshold Voltage	V _{DS} = V _{GS} , I _{DS} = 250 μ A	0.65	0.85	1.10	V	
R _{DS(on)}	Drain-to-Source On-Resistance	V _{GS} = 1.8 V, I _{DS} = 0.5 A	310			400	mΩ
		V _{GS} = 2.5 V, I _{DS} = 0.5 A	170			225	mΩ
		V _{GS} = 4.5 V, I _{DS} = 0.5 A	140			180	mΩ
g _{f/s}	Transconductance	V _{DS} = 6 V, I _{DS} = 0.5 A	3.2			S	
DYNAMIC CHARACTERISTICS							
C _{iss}	Input Capacitance	V _{GS} = 0 V, V _{DS} = 6 V, f = 1 MHz	155			200	pF
C _{oss}	Output Capacitance		47			62	pF
C _{rss}	Reverse Transfer Capacitance		2.5			3.3	pF
R _G	Series Gate Resistance		23				Ω
Q _g	Gate Charge Total (4.5 V)	V _{DS} = 6 V, I _{DS} = 0.5 A	1060			1400	pC
Q _{gd}	Gate Charge Gate-to-Drain		140				pC
Q _{gs}	Gate Charge Gate-to-Source		230				pC
Q _{g(th)}	Gate Charge at V _{th}		155				pC
Q _{oss}	Output Charge	V _{DS} = 6 V, V _{GS} = 0 V	1120				pC
t _{d(on)}	Turn On Delay Time	V _{DS} = 6 V, V _{GS} = 4.5 V, I _{DS} = 0.5 A, R _G = 2 Ω	3.7				ns
t _r	Rise Time		1.5				ns
t _{d(off)}	Turn Off Delay Time		11.0				ns
t _f	Fall Time		3.8				ns
DIODE CHARACTERISTICS							
V _{SD}	Diode Forward Voltage	I _{SD} = 0.5 A, V _{GS} = 0 V	0.73			0.9	V
Q _{rr}	Reverse Recovery Charge	V _{DS} = 6 V, I _F = 0.5 A, di/dt = 300 A/ μ s	1550				pC
t _{rr}	Reverse Recovery Time		6				ns

5.2 Thermal Information

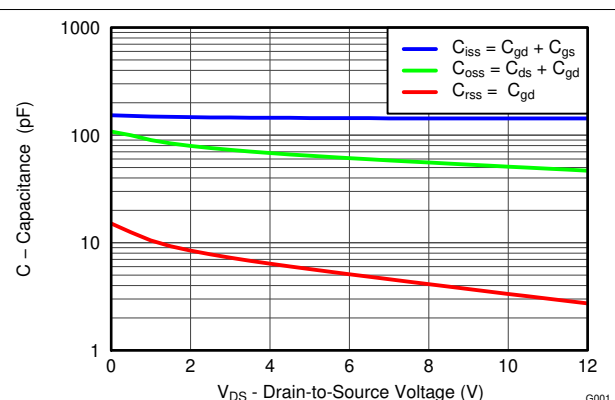
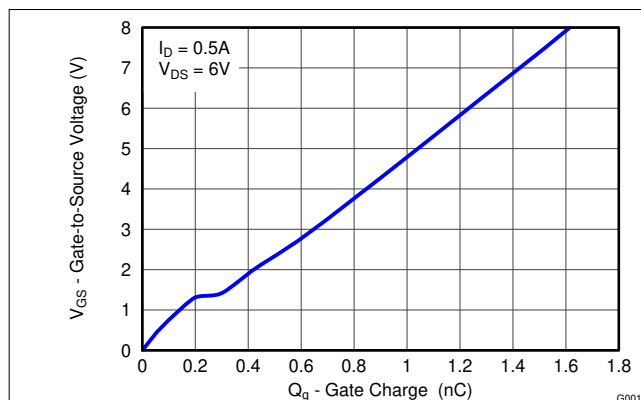
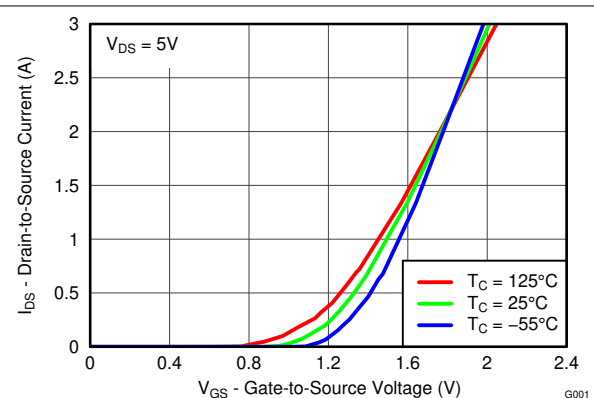
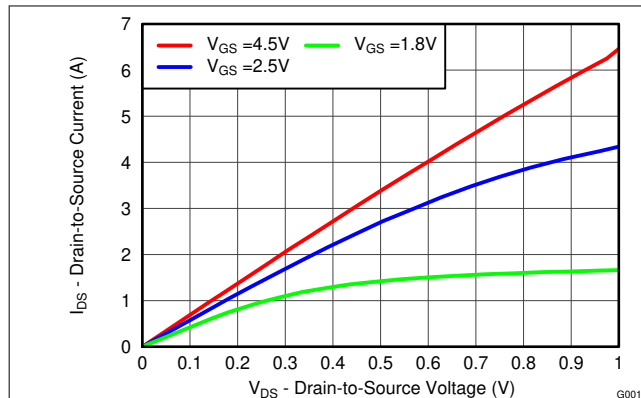
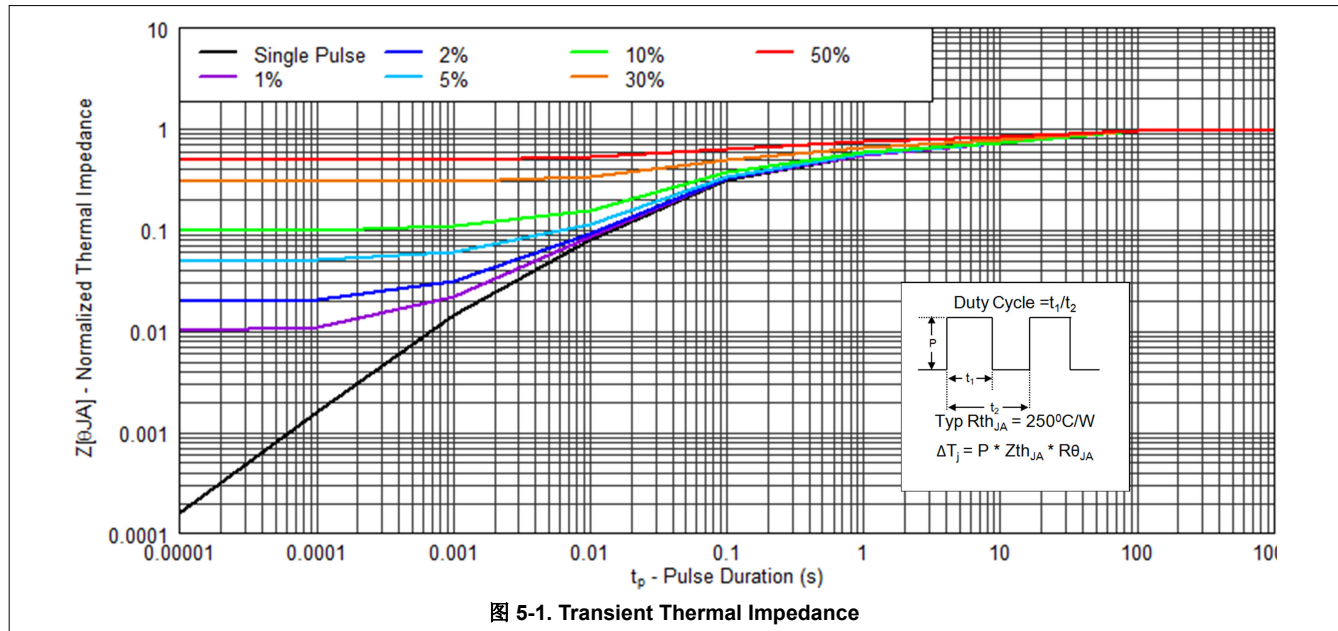
(T_A = 25°C unless otherwise stated)

THERMAL METRIC		TYPICAL VALUES	UNIT
R _{θJA}	Junction-to-Ambient Thermal Resistance ⁽¹⁾	90	°C/W
	Junction-to-Ambient Thermal Resistance ⁽²⁾	250	

- (1) Device mounted on FR4 material with 1 inch² (6.45 cm²), 2 oz. (0.071 mm thick) Cu.
 (2) Device mounted on FR4 material with minimum Cu mounting area.

5.3 Typical MOSFET Characteristics

($T_A = 25^\circ\text{C}$ unless otherwise stated)



5.3 Typical MOSFET Characteristics (continued)

($T_A = 25^\circ\text{C}$ unless otherwise stated)

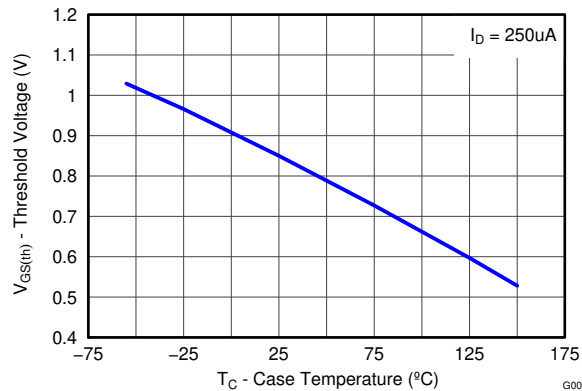


图 5-6. Threshold Voltage vs Temperature

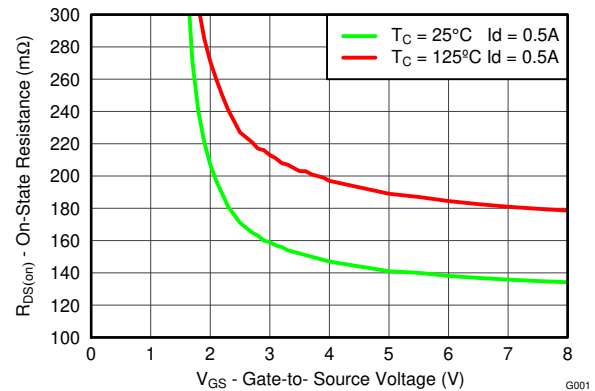


图 5-7. On-State Resistance vs Gate-to-Source Voltage

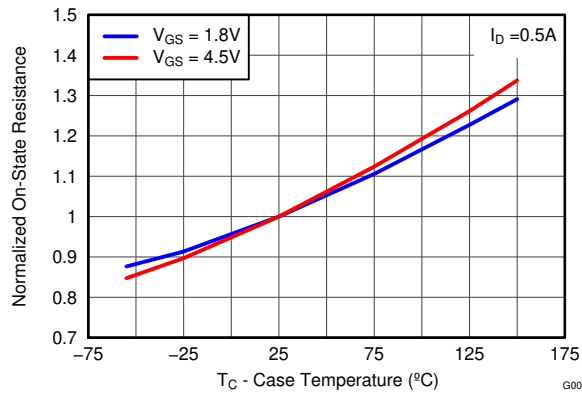


图 5-8. Normalized On-State Resistance vs Temperature

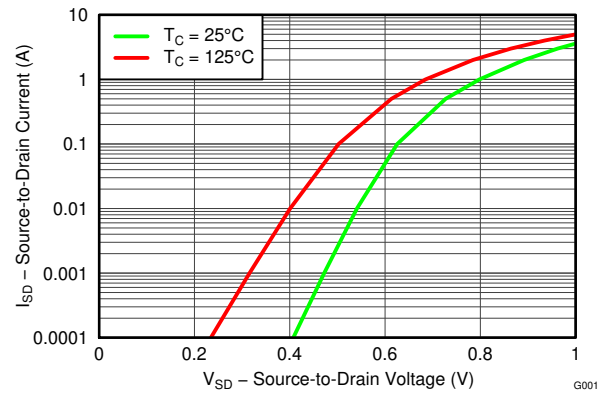


图 5-9. Typical Diode Forward Voltage

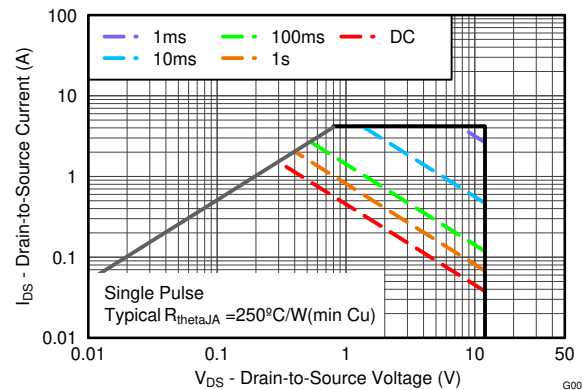


图 5-10. Maximum Safe Operating Area (SOA)

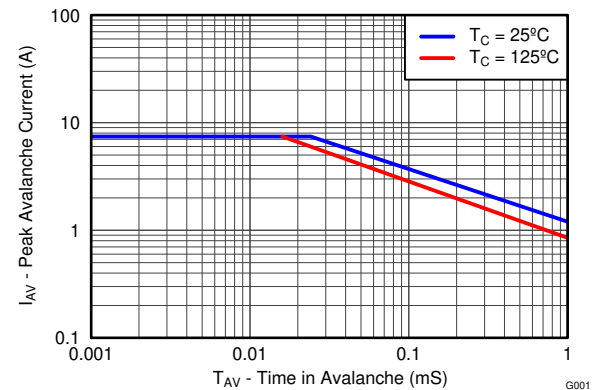


图 5-11. Single Pulse Unclamped Inductive Switching

5.3 Typical MOSFET Characteristics (continued)

($T_A = 25^\circ\text{C}$ unless otherwise stated)

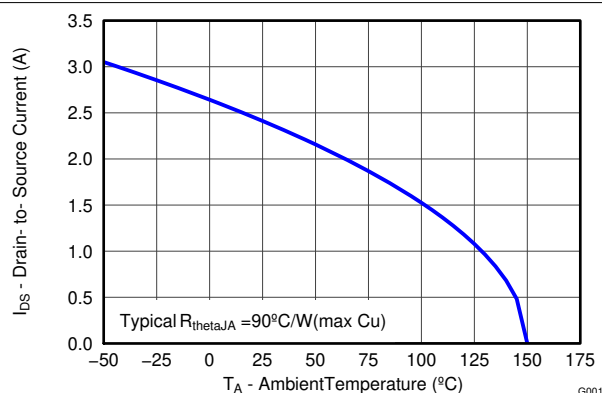


图 5-12. Maximum Drain Current vs Temperature

6 Device and Documentation Support

6.1 Trademarks

FemtoFET™ is a trademark of Texas Instruments.

所有商标均为其各自所有者的财产。

6.2 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

6.3 术语表

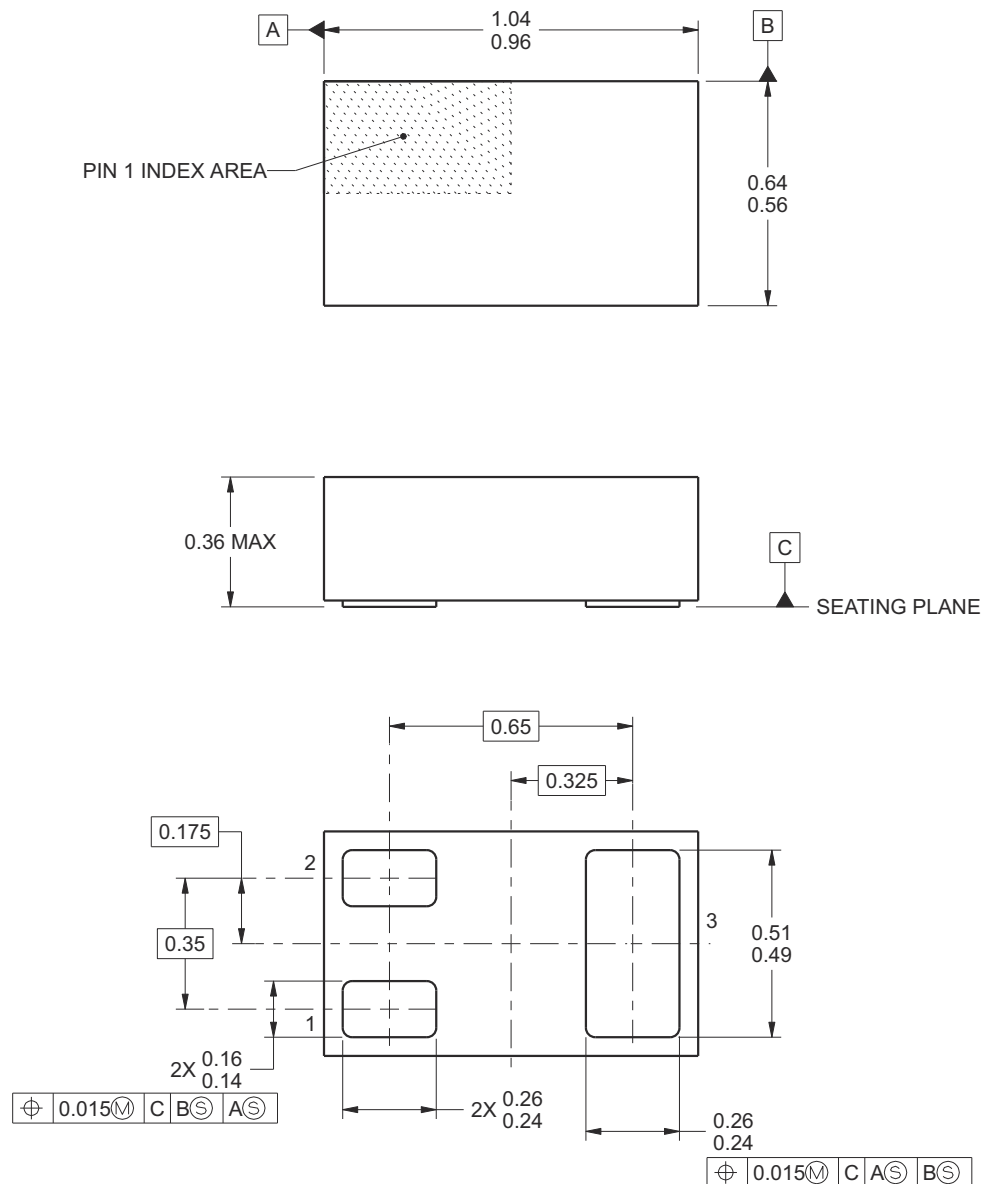
TI 术语表

本术语表列出并解释了术语、首字母缩略词和定义。

7 Mechanical, Packaging, and Orderable Information

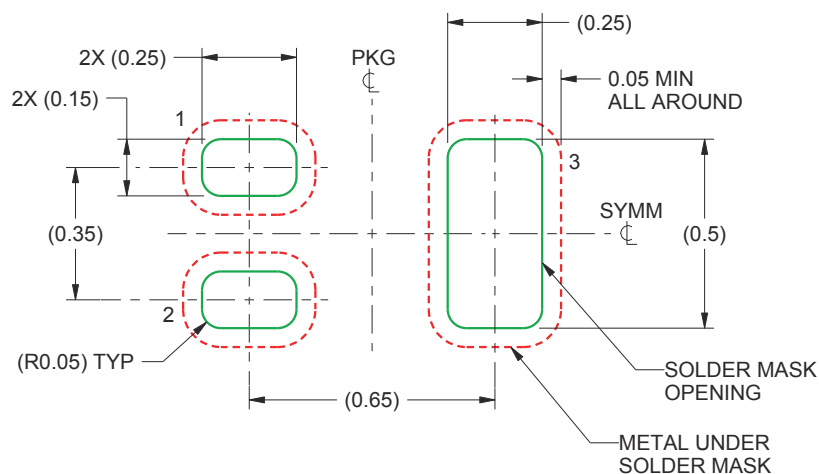
The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

7.1 Mechanical Dimensions



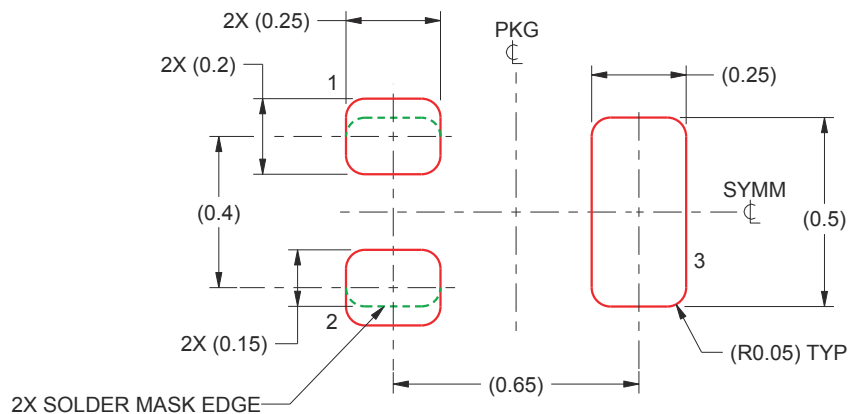
- A. All linear dimensions are in millimeters (dimensions and tolerancing per AME T14.5M-1994).
- B. This drawing is subject to change without notice.
- C. This package is a PB-free solder land design.

7.2 Recommended Minimum PCB Layout



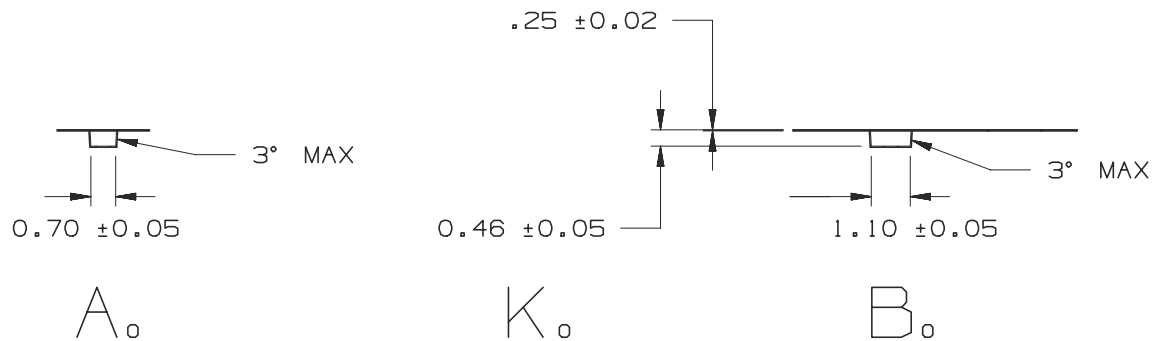
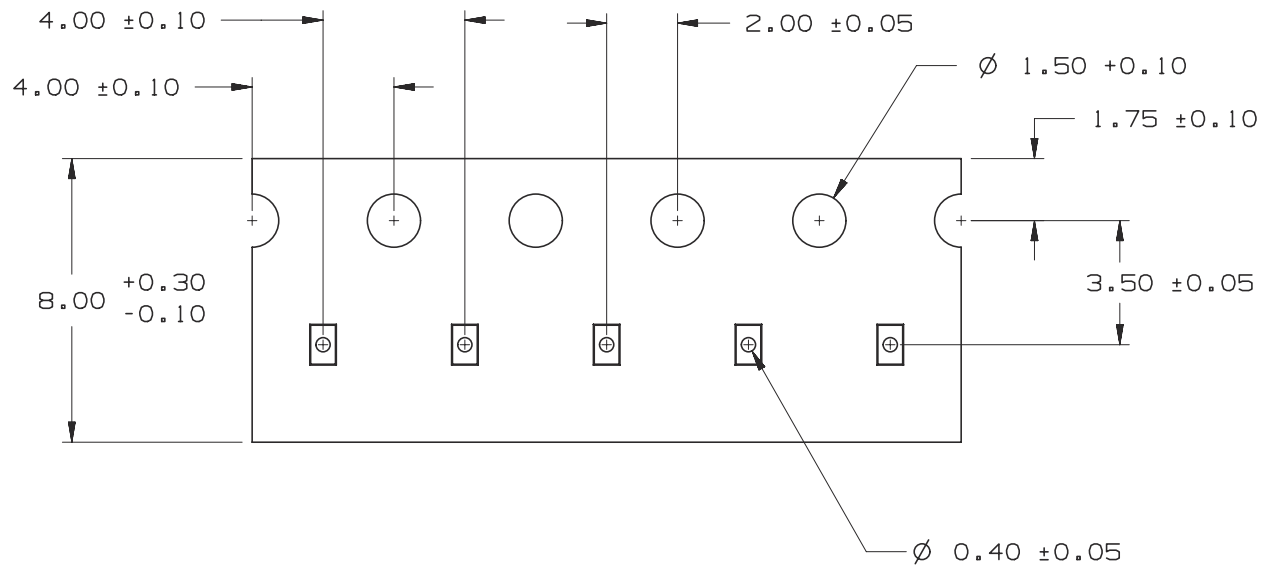
- A. All dimensions are in millimeters.
- B. For more information, see [FemtoFET Surface Mount Guide](#) (SLRA003D).

7.3 Recommended Stencil Pattern



- A. All dimensions are in millimeters.

7.4 CSD13381F4 Embossed Carrier Tape Dimensions



- A. Pin 1 is oriented in the top-right quadrant of the tape enclosure (quadrant 2), closest to the carrier tape sprocket holes.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CSD13381F4	Active	Production	PICOSTAR (YJC) 3	3000 LARGE T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	DQ
CSD13381F4.B	Active	Production	PICOSTAR (YJC) 3	3000 LARGE T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	DQ
CSD13381F4T	Active	Production	PICOSTAR (YJC) 3	250 SMALL T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	DQ
CSD13381F4T.B	Active	Production	PICOSTAR (YJC) 3	250 SMALL T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	DQ

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

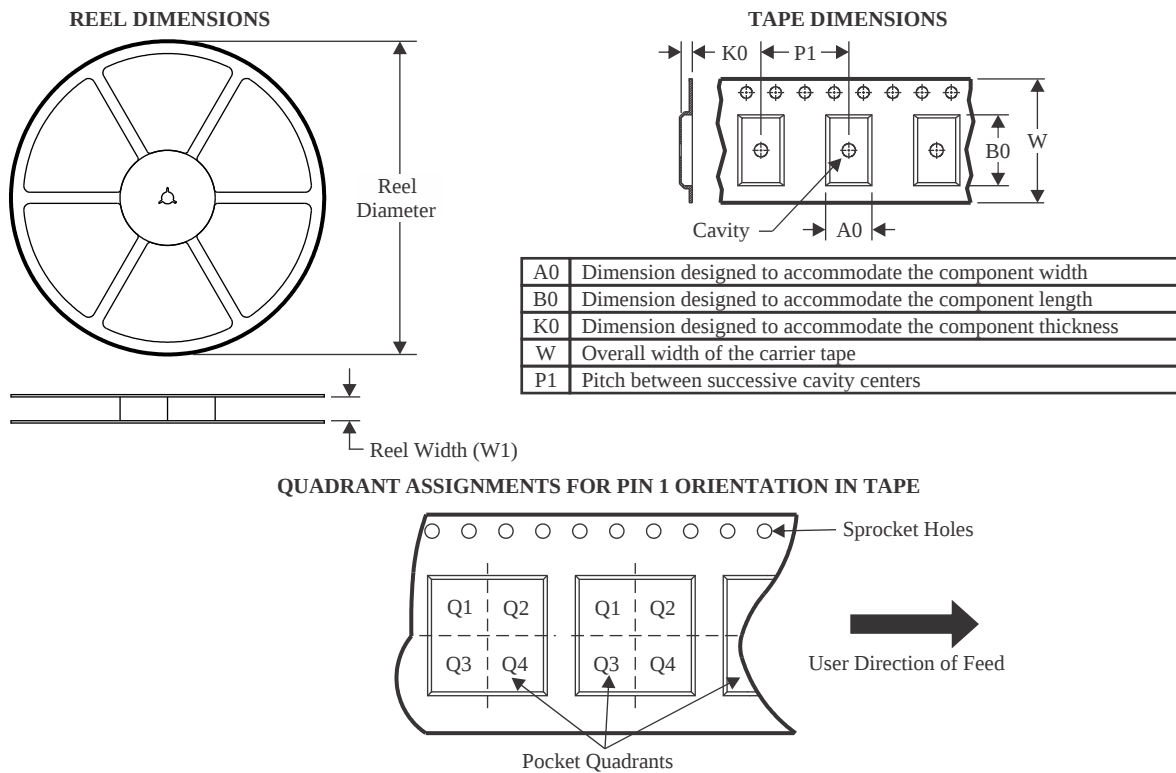
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD13381F4	PICOSTAR	YJC	3	3000	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2
CSD13381F4T	PICOSTAR	YJC	3	250	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD13381F4	PICOSTAR	YJC	3	3000	182.0	182.0	20.0
CSD13381F4T	PICOSTAR	YJC	3	250	182.0	182.0	20.0

重要通知和免责声明

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